Cycle 24 STIS Final Calibration Plan

STIS Team

Cycle 24 Instrument Usage Statistics Based on Approved Programs

• STIS orbits comprise ~27.6% of all GO prime orbits in Cycle 24

Instruments	Prime Orbits Usage	SNAP Orbit Usage
ACS	13.9%	25.4%
COS	20.5%	I 6.8%
STIS	27.6%	0.0%
WFC3	37.9%	57.7%
FGS	0.0%	0%

STIS Cycle 24 Usage Statistics for each Configuration/Mode

Configuration/Mode		e of STIS Prime osure Time	Percentage of STIS SNAP Exposure Time		
	C23	C24	C23	C24	
ССD	24.1%	31.1%	100%		
CCD/Imaging	0.7%	1.1%			
CCD/Spectroscopy	23.4%	30.0%	100%		
MAMA/FUV	35.7%	41.3%			
FUV/Imaging	11.0%	14.3%			
FUV/Spectroscopy	24.7%	27.0%			
MAMA/NUV	40.2%	27.6%			
NUV/Imaging	0.8%	0.1%			
NUV/Spectroscopy	39.2%	27.5%			

STIS Cycle 24 Usage Statistics for each Grating/Mirror Combination

Configuration/Mode	Grating/Mirror		of STIS Prime posure Time	Percentage of STIS SNAP science Exposure Time		
		C23	C24	C23	C24	
STIS/CCD	G230LB	7.9%	0.1%	59.7%		
(31.1%)	G230MB					
	G430L	6.4%	19.6%	15.7%		
	G430M	0.4%	0.2%			
	G750L	7.6%	8.1%	24.6%		
	G750M	1.3%	2.0%			
	MIRROR/CORON	0.7%	1.1%			
STIS/MAMA-FUV	EI40H	7.7%	2.0%			
(41.3%)	EI40M	4.4%	7.1%			
	G140L	7.3%	8.2%			
	G140M	5.3%	9.7%			
	MIRROR	11.0%	14.3%			
stis/mama-nuv	E230H	14.8%	9.4%			
(27.6%)	E230M	7.4%	10.5%			
	G230L	17.2%	7.7%			
	MIRROR	0.8%	0.1%			

STIS Calibration and Monitor Orbits Approved by Cycle

	# of Programs	External Orbits	Parallel Orbits	Internal Orbits	Total Orbits
Cycle 17	25	68	0	1816	1884
Cycle 18	20	22	0	1370	1392
Cycle 19	18	21	0	1418	1439
Cycle 20	20	21	0	1391	1412
Cycle 21	20	21	0	1392	1413
Cycle 22	19	21	0	1387	1408
Cycle 23	22	31	I	1380	1416
Cycle 24	7* + 4	21 + 5	3#	345 + <mark> 0</mark>	1369 <mark>+ 15</mark>

* Includes approved early submission programs only

3 parallel orbits are requested by COS Team

Requesting additional programs/orbits indicated in red

STIS Cycle 24 Calibration and Monitoring Orbits Requested

Prop. ID	Title	External	External Parallel	Internal	Frequency (orbits x repeats)	Cycle 23 Allocation	
CCD Monit	tors						
	STIS CCD Performance Monitor			14	2x7	14	
	STIS CCD Dark Monitor			730	2x242 + 1x246	732	* Internal
	STIS CCD Bias and Read Noise Monitor			369	x 82 + x 83+ x4	370	parallel orbits > 1800s.
	STIS CCD Hot Pixel Annealing			39*	3x13	39	~ 1800s.
	STIS CCD Spectroscopic Flat-Field Monitor			19	Ix10 +9	19	
	STIS CCD Imaging Flat-Field Monitor			4	lx4	4	() Indicates contingency
	STIS CCD Spectroscopic Dispersion Solution Monitor			3	3x1	3	orbits not
	STIS CCD Sparse Field CTE			50	50x I	50	included in Cycle 24
	STIS CCD Full Field Sensitivity	I		0	İxl	17	request.
	STIS Slit Wheel Repeatability			I	İxl	I	Routine
	STIS CCD Spectroscopic Sensitivity Monitor	5			L 1x3, M 2x1	5	program being
MAMA Mo	nitors	-	:				discussed today
	STIS MAMA Spectroscopic Dispersion Solution Monitor			7	7x1	7	Red means new
	STIS MAMA Full Field Sensitivity	3			lx3	3	♦Requesting
	STIS MAMA Spectroscopic Sensitivity and Focus Monitor / COS Observations of Geocoronal Ly α Emission	12	3		1x3/L, 1x1/M, 2x4/E	12	Cy 23 special program
	STIS FUV MAMA Dark Monitor			54	6x9	54	become
	STIS NUV MAMA Dark Monitor			52	2x26	52	contingency program in Cy
	STIS MAMA FUV Flat-Field Monitor			*	IxII	н	24
	STIS MAMA Fold Distribution			2	2x1	2	
Special pro	gram						
	Monitoring the 3 Primary WD Standard Stars	5			5x1	-	
Contingen	cy programs						
	STIS MAMA Anomalous Recovery			(6)		(6)	
	STIS Focus Parallel Measurements	(1)	(1)		İxl	1	
TOTAL	Cycle 24 orbit request	26 + (1)	3 + (I)	1355 + (6)		Ext: 3 + Int: 380+(6)	

Cycle 24 STIS Calibration Plan

STIS Team

6/2/2016

STIS Calibration and Monitor Orbits Approved by Cycle

	# of Programs	External Orbits	Parallel Orbits	Internal Orbits	Total Orbits
Cycle 17	25	68	0	1816	1884
Cycle 18	20	22	0	1370	1392
Cycle 19	18	21	0	1418	1439
Cycle 20	20	21	0	1391	1412
Cycle 21	20	21	0	1392	1413
Cycle 22	19	21	0	1387	1408
Cycle 23	22	31	I	1380	1416
Cycle 24	18*	22	4 [#]	1345	1371

* Includes early submission programs only

3 parallel orbits are requested by COS Team

STIS Cycle 24 Calibration and Monitoring Orbits Requested

Prop. ID	Title	External	External Parallel	Internal	Frequency (orbits x repeats)	Cycle 23 Allocation	
CCD Monit	tors						
	STIS CCD Performance Monitor			14	2x7	14	
	STIS CCD Dark Monitor			730	2x242 + 1x246	732	* Internal parallel orbit
	STIS CCD Bias and Read Noise Monitor			369	1x182 + 1x183+1x4	370	> 1800s.
	STIS CCD Hot Pixel Annealing			39*	3x13	39	Green mean
	STIS CCD Spectroscopic Flat-Field Monitor			19	Ix10 +9	19	"executing o
	STIS CCD Imaging Flat-Field Monitor			4	lx4	4	alternating cycle only"
	STIS CCD Spectroscopic Dispersion Solution Monitor			TBD	TBD	3	cycle only
	STIS CCD Sparse Field CTE			50	50x I	50	
	STIS CCD Full Field Sensitivity	I		0	İxl	17	() Indicates contingency
	STIS Slit Wheel Repeatability			I	İxl	I	orbits not
	STIS CCD Spectroscopic Sensitivity Monitor	5			L 1x3, M 2x1	5	included in Cycle 24
	STIS Focus Parallel Measurements ◆	I	I		İxl	I	request.
MAMA Mo	nitors						♦Requestin
	STIS MAMA Spectroscopic Dispersion Solution Monitor			TBD	TBD	7	Cy 23 specia
	STIS MAMA Full Field Sensitivity	3			lx3	3	program become reg
	STIS MAMA Spectroscopic Sensitivity and Focus Monitor / COS Observations of Geocoronal Ly α Emission	12	3		1x3/L, 1x1/M, 2x4/E	12	program
	STIS FUV MAMA Dark Monitor			54	6x9	54	Blue: change from last cyc
	STIS NUV MAMA Dark Monitor			52	2x26	52	from last cyc
	STIS MAMA FUV Flat-Field Monitor			*	IxII	П	TBD: Phase to be
	STIS MAMA Fold Distribution			2	2x1	2	submitted la
Contingen	cy program	=					
	STIS MAMA Anomalous Recovery			(6)		(6)	
TOTAL	Cycle 24 orbit request	22	4	1345 + (6)		Ext: 3 + Int: 380+(6)	

STIS Cycle 24 Calibration: Changes from Cycle 23

- CCD Dark Monitor program will be split into three programs instead of two for manageability.
- CCD Dark Monitor and Bias and Read Noise Monitor have orbits reduced because of no leap day.
- CCD Full Field Sensitivity program is reduced by 16 internal orbits that were needed for CTI testing in Cy 23.
- Requesting to add Focus Parallel Measurements as a regular calibration program to be repeated every cycle.
- MAMA Spectroscopic Sensitivity program will execute one fewer parallel orbit for COS airglow observations, as requested by COS team.

STIS Cycle 24 Calibration Programs to be Submitted Later

- The performance of the STIS calibration lamps is under current investigation. Efforts are being made to assure that the accuracy of the wavelength calibration for all spectroscopic modes is maintained as the calibration lamps continue to fade. The following regular calibration programs will be submitted later, pending the results of this work:
 - STIS CCD Spectroscopic Dispersion Solution Monitor
 - STIS MAMA Spectroscopic Dispersion Solution Monitor

STIS/CCD Programs

Note: STIS Cycle 24 Phase Is Include Cycle 23 Usage Statistics

CCD Performance Monitor PI:Allyssa Riley

Purpose	To measure the baseline performance of the CCD detector.
Description	This program monitors the performance of the CCD detector on orbit for amplifier D only. Bias and flat field exposures are taken to measure read noise, CTE (EPER test), spurious charge, and gain values with full frame observations. Bias exposures are also taken in sub- array readouts to check the bias level for ACQ and ACQ/PEAK observations. All orbits < 1800s
Fraction GO/GTO Programs Supported	24% of STIS total exposure time.
Resources Required: Observations	14 internal orbits performed in 2 groups of 7
Resources Required: Analysis	
Products	Possible update of the gain, bias level, and read noise values in ccdtab. This also provides a relative measure of CTI via the extended pixel edge response test. Possible flight software updates of table CCDBiasSubtractionValue. Summary in the end of cycle ISR and updates to the STIS monitor webpages.
Accuracy Goals	Read noise good to +/- 0.3 ADU, gain error < 0.08 ADU
Scheduling & Special Requirements	Visits occur every 6 months in Mar and Sept.
Changes from Cycle 23	No changes

CCD Dark Monitor (Parts 1, 2 and 3) PI:Allyssa Riley

Purpose	Monitor dark current for the STIS CCD.
Description	Routine monitoring with Amp D and GAIN = 1: obtain 2 visits
Fraction GO/GTO Programs Supported	24% of STIS total exposure time
Resources Required: Observations	242 (part I) + 242 (part 2) + 246 (part 3) internal orbits <1800s.
	6 FTE weeks; Retrieve and construct superdarks. These superdarks are compared to previous superdarks and the image statistics are checked to see if there are any anomalous statistical deviations. CTI analysis based on short darks is performed.
Products	Weekly CDBS reference files (superdarks) and a summary in the end of cycle ISR and update of the monitor webpage.
Accuracy Goals	Superdark rms < 0.012 e-/s and S/N > 1.0 per pixel in superdarks.
Scheduling & Special Requirements	Two orbits each day.
Changes from Cycle 23	This program has been split into 3 parts to make the proposal size more manageable.

CCD Bias and Read Noise Monitor (Parts 1 & 2) PI:Allyssa Riley

Purpose	Monitor the bias in the 1x1 bin settings at gain=1, and 1x1 at gain = 4, to build up high S/N superbiases and track the evolution of hot columns. Also GAIN=1 and GAIN=4, 1x1 biases through AMPS A and C to use in combination with biases taken through AMP D for monitoring of the read noise
Description	Take full frame bias exposures in the 1×1 bin settings at GAIN = 1, and at GAIN = 4 with nominal AMP D. Take full frame biases through AMPs A and C in GAIN = 1 and 4 as well for performing read noise monitoring. All exposures are internal and fit in occultation orbits. In addition to routine monitoring, during one month we use 4 additional internal orbits of GAIN = 1, AMP A biases in support of absolute CTI measurements.
Fraction GO/GTO Programs Supported	24% of STIS total exposure time
Resources Required: Observations	182 (part 1) + 183 (part 2) internal orbits + 4 (CTI) internal orbits <1800s
	2 FTE weeks. Retrieve and construct superbiases. These are compared to previous superbiases and the image statistics are checked to see if there are any anomalous deviations. Biases with AMPS A and C allow for monitoring of the read noise.
Products	Weekly CDBS reference files (superbiases) and a summary in the end of cycle ISR
Accuracy Goals	Superbiases RMS < 0.95 e- at GAIN = 1 1x1 and RMS < 1.13 e- at GAIN = 4 1x1, S/N > 1 per pixel.
Scheduling & Special Requirements	One orbit per day for the routine monitor. The additional bias for AMP A should be taken the same month as AMP A darks for CTI analysis
Changes from Cycle 23	One fewer internal orbit than Cycle 23 so as not to account for a leap day.

STIS CCD Hot Pixel Annealing PI:Allyssa Riley

Purpose	To anneal hot pixels and the effectiveness of the CCD hot pixel annealing is assessed by measuring the dark current behavior before and after annealing.
Description	The characteristics of the CCD will first be defined by a series of bias, dark and flat-field exposures taken before the anneal. The CCD Thermoelectric cooler will be turned off to allow the CCD detector temperature to rise from ~ -80 C to +5 C. The CCD will be left in the uncooled state for approximately 12 hours. At the end of this period the Thermoelectric cooler is turned back on and the CCD is cooled to its normal operating temperature. Since the CCD on Side-2 does not have thermistor, a 4 hour period, at a minimum, is necessary to ensure that the CCD is cool and stable. After the CCD has stabilized, bias, dark and flat-field images will be repeated to check for changes in the CCD characteristics. The flat-field exposures will permit evaluation of any window contamination acquired during the annealing period. Pure parallel mode.
Fraction GO/GTO Programs Supported	24% of STIS total exposure time.
Resources Required: Observations	39 internal orbits and all orbits >1800s.
	2 FTE weeks. By comparing the number of hot pixels before and after the anneal, we see if the hot pixels decrease and estimate the number of hot pixels that persist after the process.
Products	Hot pixel growth rate, median dark count rate, and a summary in the end of cycle ISR
Accuracy Goals	Measure the growth rate of hot pixels to within 1% if possible
Scheduling & Special Requirements	Pure parallel mode exposures.Anneals will execute every 4 th week using 3 orbits.
Changes from Cycle 23	No changes.

STIS CCD Spectroscopic Flat-Field Monitor PI: Molly Peeples

Purpose	Obtain medium resolution grating flats to determine the pixel-to-pixel variation for spectroscopic observations and produce the cycle 24 reference p-flat (M and L modes).
Description	We use the tungsten lamp and the G430M grating to determine the pixel-to-pixel variation of the STIS CCD in spectroscopic mode. The flat exposures are taken with the 50CCD and 52x2 apertures at 5 offset positions in order to map -with a sufficient SNR- the whole sensitive area of the detector. The expected signal is ≥1.4E6 ADU/ pixels; while the expected accuracy will be ≤1.5%. All orbits are less < 1800 s.
Fraction GO/GTO Programs Supported	24% of STIS total exposure time.
Resources Required: Observations	19 internal orbits <1800s
Resources Required: Analysis	2.5 weeks FTE
Products	Reference files, summary in end of cycle ISR and ISR as applicable
Accuracy Goals	≤I.5% flat field accuracy
- -	9 orbits with G430M/5612 & 50CCD spread across the cycle; I visit every ~40 days 10 orbits with the G430M/5612 & 52x2
Changes from Cycle 22	No changes

STIS CCD Imaging Flat-Field Monitor PI: John Debes

Purpose	Purpose: Collect high SNR white light imaging flats (aperture=50CCD) for monitoring purposes and to create a new reference p-flat for chronographic (and imaging) observations.
Description	Once every 3 months, obtain a series of imaging CCD flats using the MIRROR and the unfiltered 50CCD aperture. The 3 months cadence will allow us to keep monitoring possible (but unlikely) variations across the cycle; while the combined observations will allow us to obtain an average signal ~620000 ADU/pix (similarly to the past cycles) and create a high accuracy (~1%) imaging p-flat. The remaining time in each orbit/visit will be used to monitor the stability of the CORON aperture due to the MSM limited reproducibility.
Fraction GO/GTO Programs Supported	24% of STIS total exposure time.
Resources Required: Observations	4 internal orbits
Resources Required: Analysis	4 weeks FTE
Products	Reference p-flat and TIR or ISR as relevant.
Accuracy Goals	~1% flat field accuracy
Scheduling & Special Requirements	I orbit every 3 months.
Changes from Cycle 23	None.

CCD Sparse Field CTE Internal Sean Lockwood

Purpose	Re-establish an accurate correction for parallel register CTE losses that can be used for direct analysis of science data with negligible background. Do measurements for one gain setting (GAIN=4), alternating with GAIN=1 every-other-cycle.
Description	The sparse field CTE will be measured via internal calibration lamp observations taken through narrow slits. Using the onboard tungsten lamp, narrow slit images are projected at different positions on the detector. At each position a series of exposures is taken alternating between the 'A' and 'C' amplifiers for readout. The further the charge needs to be shifted to be read out, the more charge it will lose. For the parallel CTE measurement, the test will use the the cross disperser slits: 0.05x31NDB and 0.05x31NDA. In order to test the effects of different bias voltages the whole series of exposures are executed once for GAIN=4 and once for GAIN=1 every-other cycle; this process requires a total of 50 orbits per cycle which includes various sets of biases. For the CTE pixel based correction, the test requires 8 orbits for darks read out with amplifier A.
Fraction GO/GTO Programs Supported	24% of STIS total exposure time (cycle 23)
Resources Required: Observations	50 internal visits (7/50 visits will exceed the 1800 s limit by ~100 s in order to capture the full sequence of exposures required for best analysis.)
Resources Required: Analysis	3 FTE weeks
Products	Determine slope for time dependent empirical flux correction of CTE, possible update of ccdtab reference file, and a summary in the end of cycle ISR.
Accuracy Goals	1%
	Schedule between 01 November 2016 and 01 January 2017. Visits should execute in order.
Changes from Cycle 23	Data taken for gain=4 instead of gain=1; alternates every cycle.

STIS CCD Full-Field Sensitivity PI: John Debes

Purpose	To monitor CCD sensitivity over the whole field of view.
Description	Measure a photometric standard star field in Omega Cen in 50CCD annually to monitor CCD sensitivity over the whole field of view. Keep the spacecraft orientation within a suitable range (+/- 5 degrees) to keep the same stars in the same part of the CCD for every measurement. This test will give a direct transformation of the 50CCD magnitudes to the Johnson-Cousins system for red sources. These transformations should be accurate to 1%. The stability of these transformations will be measured to the sub-percent level. These observations also provide a check of the astrometric and PSF stability of the instrument over its full field of view. All external orbits > 1800s.
Fraction GO/GTO Programs Supported	24%
Resources Required: Observations	l external
Resources Required: Analysis	I FTE week
Products	Summary in the end of cycle ISR
Accuracy Goals	1%
Scheduling & Special Requirements	ORIENT 310.0D TO 310.0 D; BETWEEN 15-JAN-2017:00:00:00 AND 20-MAR-2017:00:00:00
Changes from Cycle 23	Deletion of 16 internal orbits to create dark and bias observations in Amp A used for testing of CTI in Cycle 23.

STIS Slit Wheel Repeatability PI: TalaWanda Monroe

Purpose	To test the repeatability of slit wheel motions.
Description	A sequence of lamp spectra taken using grating G230MB and the three smallest long slits 52X0.1, 52X0.2, and 52X0.05.
Fraction GO/GTO Programs Supported	
Resources Required: Observations	11 internal orbit 1/4 expositions ~40 minutes total) once per vear
Resources Required: Analysis	
Products	The average and maximum shifts observed in the dispersion and the spatial direction. Summary in end of cycle ISR
Accuracy Goals	Shifts should be smaller than 0.5 pixels.
Scheduling & Special Requirements	
Changes from Cycle 23	No changes

STIS CCD Spectroscopic Sensitivity Monitor PI: TalaWanda Monroe

Purpose	Monitor the spectroscopic sensitivity of the STIS CCD using both low- and medium-resolution gratings to reveal contamination issues that may affect the spectroscopic throughput.
Description	This program will monitor the STIS CCD spectroscopic sensitivity using a high-declination spectroscopic calibration star (AGK+81D266). The results will be compared to previous observations to detect trends. The L modes will be observed at the nominal and EI positions every four months with one orbit per visit. The M modes will be observed at the nominal and EI positions as well, once per year with two orbits per visit.
Fraction GO/GTO Programs Supported	24%, Cycle 23
Resources Required: Observations	5 external orbits
Resources Required: Analysis	7 FTE weeks: 3 FTE weeks for sensitivity analysis, 2 weeks for ISR, 2 FTE weeks for CTE correction verification
Products	Updated STIS TDSTAB file, an ISR on STIS sensitivity monitoring, summary in end of cycle ISR
Accuracy Goals	Minimum signal to noise of 50 per resolution element at the least sensitive wavelength.
Scheduling & Special Requirements	I orbit every 4 months for L modes. 2 orbits/year for M modes.
Changes from Cycle 23	No changes

STIS Focus Parallel Measurements Charles Proffitt

Purpose	To determine the focus offset between the STIS OII filter and that of WFC3/UVIS and ACS/WFC. This will allow any long term secular changes in the relative focus of the three instruments to be determined.
Description	A UV bright star will be observed with STIS F28X50OII while parallel observations are done of rich star fields in 47 Tuc using WFC3 F410M and ACS F502N. This prime/parallel grouping is repeated 4 times for STIS+WFC3 using a small dither pattern. During two of these iterations there is also time to include a parallel ACS F502N image. Phase retrieval analysis should allow measurement of the relative focus of the three instruments independent of any uncertainties in the breathing model.
Fraction GO/GTO Programs Supported	100% of STIS external observations are affected by the focus
Resources Required: Observations	I external orbit, I parallel orbit
Resources Required: Analysis	
Products	A measurement of the focus offset between STIS and ACS and WFC3. Possible recommendations for adjustments to the STIS corrector.
Accuracy Goals	< I micron of equivalent secondary despace
	The ORIENT requirement of 255 to match previous iterations of this setup and ensure that the same stars are viewed in WFC3 and ACS will force execution of this program to occur between 26-May-2017 and 13-Jul-2017.
Changes from Cycle 23	None

STIS/MAMA Programs

STIS MAMA Full-Field Sensitivity PI: John Debes

Purpose	To monitor the sensitivity of the FUV-MAMA and NUV-MAMA over the full field
Description	By observing the globular cluster NGC6681 once every year at roughly the same orientation, we will monitor the full-field sensitivity of the MAMA detectors and their astrometric and PSF stability. These observations will be used to look for contamination, throughput changes, or formation of color centers in the photocathode and window that might be missed by spectroscopic monitoring or difficult to interpret in flat-fielding. Although this test is done using MAMA imaging modes, the confirmation of detector stability and uniformity provided by this monitor is important for spectroscopic observations as well. All orbits > 1800s.
Fraction GO/GTO Programs Supported	76% of STIS prime exposure time
Resources Required: Observations	3 external orbits
Resources Required: Analysis	I FTE week
Products	Summary in the end of cycle ISR
Accuracy Goals	1%
Scheduling & Special Requirements	Should roughly match most common orient from previous observations. ORIENT 260.0D TO 266.0 D; BEFORE 16-JUN-2017:00:00:00
Changes from Cycle 23	No Changes

STIS MAMA Spectroscopic Sensitivity & Focus Monitor / COS Observations of Geocoronal Lyα Emission PI:TalaWanda Monroe

Purpose	Monitor the sensitivity of each STIS MAMA grating mode to detect any changes due to contamination or other effects, and monitor the STIS focus in spectroscopic and imaging modes.
Description	 SENSITIVITY: Obtain exposures in each of the two low-resolution MAMA spectroscopic modes every 4 months, in each of the 2 medium-resolution modes once a year, and in each of the 5 echelle modes every 3 months, using unique calibration standards for each mode (L: GRW+70D5824, M: AGK+81D266, E: BD+28D4211), and compare the results to the first observations to detect any trends. FOCUS: For this cycle we will continue to monitor the STIS focus (small aperture throughput as a function of UV wavelength) by including a direct comparison between the G230LB 0.1X0.09 and 52x2 throughput, as well as a narrow band OII CCD image during each L-Mode visit. We will continue to also include an OII image with the M-mode visit. AIRGLOW: COS/FUV airglow spectra will be obtained in parallel before move to LP4.
Fraction GO/GTO Programs Supported	Focus monitor: 100% of STIS exposures- Sensitivity monitor: 76% of STIS exposures- Airglow parallel: 45% COS exposures (Cycle 23)
Resources Required: Observations	12 external orbits, 3 parallel COS orbits
Resources Required: Analysis	
Products	Updated STIS TDSTAB file and ISRs on STIS sensitivity monitoring and focus monitoring. Summary in the end of cycle ISR.
Accuracy Goals	Minimum signal to noise of 50 per resolution element at the least sensitive wavelength. 10% for focus changes.
Scheduling & Special Requirements	Visits need to be approximately equally spaced throughout the cycle.
Changes from Cycle 23	One fewer parallel COS visit.

STIS FUV MAMA Dark Monitor Sean Lockwood

Purpose	Monitor the behavior of the dark current in the FUV MAMA detector, provide data for dark count corrections for faint object observations, and also provide a check on the health of the detector
Description	Every six weeks a set of six exposures of 1300s is taken with the FUV MAMA with the shutter closed. The exposures are evenly spread over a six-hour SAA-free period.
Fraction GO/GTO Programs Supported	36% (cycle 23)
Resources Required: Observations	54 internal visits
Resources Required: Analysis	
Products	Dark current images and temperature-dependent formula for applying to an individual observation. Update to monitoring webpage.
Accuracy Goals	1%
Scheduling & Special Requirements	Groups of visits spaced apart ~every 6 weeks SAA free
Changes from Cycle 23	None

STIS NUV MAMA Dark Monitor Sean Lockwood

Purpose	Monitor the behavior of the dark current in the NUV MAMA detector, provide data for dark count corrections for faint object observations, and also provide a check on the health of the detector
Description	Every two weeks a set of two 1300 s exposures is taken with the NUV MAMA with the shutter closed. The exposures are taken separated by six hours within an SAA-free period. This separates long and short term temporal effects.
Fraction GO/GTO Programs Supported	40% (cycle 23)
Resources Required: Observations	52 internal visits
Resources Required: Analysis	2 FTE
Products	Dark reference files and tables modeling time and temperature dependence of dark rates. Update to monitoring webpage.
Accuracy Goals	1%
Scheduling & Special Requirements	Pairs of visits spaced apart every 2 weeks SAA free
Changes from Cycle 23	None

STIS FUV MAMA Flat-Field Monitor PI: Molly Peeples

Changes from Cycle 23	None. This program is run on even-numbered cycles.
Scheduling & Special Requirements	
Accuracy Goals	1.0%: Accuracy is per low-res pixel (2x2 high-res pixels).
Products	This cycle p-flat is for monitoring purposes. The achievable SNR is limited by the Poisson noise. If applicable a new reference p-flat will be created combining cycle 17, 18, 20, 22, and 24 FUV flats. ISR as applicable.
Resources Required: Analysis	
Resources Required: Observations	11 internal orbits and all orbits > 1800s.
Fraction GO/GTO Programs Supported	36% of STIS total exposure time.
Description	Past experience and observations have shown that ~ 11 visits are sufficient to create a cumulative image with ~ 2500 counts/pixel (high resolution mode, equivalent to ~ 10000 count/pixel in low resolution mode). We will start taking exposures with the setup G140M/52x0.1/1470 as in cycles 18, 20, and 22 programs. We will move to G140M/52x0.1/1420 if/when the global rate has decreased below 180000-190000 counts/sec (maximum allowed is ~ 280000 counts/sec). On the basis of past experience exposures will be at least 4740 sec long. Hence, all orbits exceed the 1800 s execution time. Different visits will have different slit offsets in order to illuminate the pixels which are normally shadowed by the slit bars.
Purpose	This program is aimed at obtaining FUV-MAMA flat-field observations to create new p-flats with a SNR of ~100 per (low resolution) pixel. The flats are obtained with the Krypton lamp and the MR grating G140M, similar to the cycle 17 and 18 programs. However the exact instrument setup (slit width and central wavelength) might change depending on the desired count level (which will be close to the internally allowed global rate limit).

STIS MAMA Fold Distribution PI: Thomas Wheeler

Purpose	The fold analysis provides a measurement of the distribution of charge cloud sizes incident upon the anode providing some measure of changes in the pulse-height distribution of the MCP and, therefore, MCP gain.
Description	While globally illuminating the detector with a flat field, the valid event (VE) rate counter is monitored, while various combinations of row and column folds are selected.
Fraction GO/GTO Programs Supported	76% of STIS prime orbits
Resources Required: Observations	2 internal orbits
Resources Required: Analysis	0.5 FTE day.
Products	The results will be sent to the STIS Team and V. Argabright of Ball Aerospace.
Accuracy Goals	N/A
Scheduling & Special Requirements	This proposal is executed annually.
Changes from Cycle 23	No changes.

Contingency Programs

STIS MAMA Recovery from Anomalous Shutdown PI: Thomas Wheeler

Purpose	Safe and orderly recovery of either MAMA detector from an anomalous shutdown.
Description	The recovery procedure consists of three separate tests (i.e. visits) to check the MAMA's health after an anomalous shutdown. Each must be successfully completed before proceeding onto the next. They are: (1) signal processing electronics check, (2) slow, intermediate voltage high-voltage ramp-up, and (3) ramp-up to full operating voltage.
Fraction GO/GTO Programs Supported	76% of STIS prime orbits
Resources Required: Observations	6 internal orbits
Resources Required: Analysis	If activated, 0.5 FTE day per test.
Products	For tests 1-3, only a Go/No-Go to proceed will be given.
Accuracy Goals	N/A
	This is a contingency proposal activated only in the event of an anomalous shutdown. This proposal is usually followed by the STIS MAMA Fold Distribution proposal.
Changes from Cycle 23	No changes

Cycle 23 Usage Statistics

STIS Cycle 24 Phase Is Include Cycle 23 Usage Statistics

Configuration/Mode		ge of STIS Prime osure Time	Percentage of STIS SNAP Exposure Time		
	C22	C23	C22	C23	
ССD	26.4%	24.1%	100%	100%	
CCD/Imaging	8.5%	0.7%			
CCD/Spectroscopy	17.9%	23.4%	100%	100%	
MAMA/FUV	42.1%	35.7%			
FUV/Imaging	1.5%	11.0%			
FUV/Spectroscopy	40.6%	24.7%			
MAMA/NUV	31.5%	40.2%			
NUV/Imaging	0.2%	0.8%			
NUV/Spectroscopy	31.3%	39.2%			

STIS Cycle 23 Usage Statistics for each Grating/Mirror Combination

Configuration/Mode	Grating/Mirror	Percentage of STIS Prime science Exposure Time		Percentage of STIS SNAP science Exposure Time	
		C22	C23	C22	C23
stis/ccd	G230LB	3.4%	7.9%		59.7
(24.1%)	G230MB	0.03%			
	G430L	1.9%	6.4%	52.1%	15.7%
	G430M	1.7%	0.4%		
	G750L	9.4%	7.6%	47.9%	24.6%
	G750M	1.5%	I.3%		
	MIRROR/CORON	8.5%	0.7%		
stis/mama-fuv	EI40H	4.2%	7.7%		
(35.7%)	EI40M	12.6%	4.4%		
	G140L	17.4%	7.3%		
	G140M	6.4%	5.3%		
	MIRROR	1.5%	11.0%		
stis/mama-nuv	E230H	0.7%	14.8%		
(40.2%)	E230M	13.1%	7.4%		
× ,	G230L	17.4%	17.2%		
	MIRROR	0.2%	0.8%		

Cycle 23 Instrument Usage Statistics Based on Approved Programs

• STIS orbits comprise ~14.3% of all GO prime orbits in Cycle 23

Instruments	Prime Orbits Usage	SNAP Orbit Usage
ACS	15.7%	11.7%
COS	18.0%	7.3%
STIS	14.3%	6.7%
WFC3	52.0%	74.3%
FGS	<0.01%	0.0%

Cycle 24 STIS Special Calibration Program Plan

Tala Monroe & STIS Team

9/26/2016

Routine STIS Spectroscopic Dispersion Solution Programs

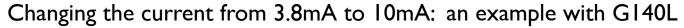
STIS CCD Spectroscopic Dispersion Solution Monitor PI: Molly Peeples

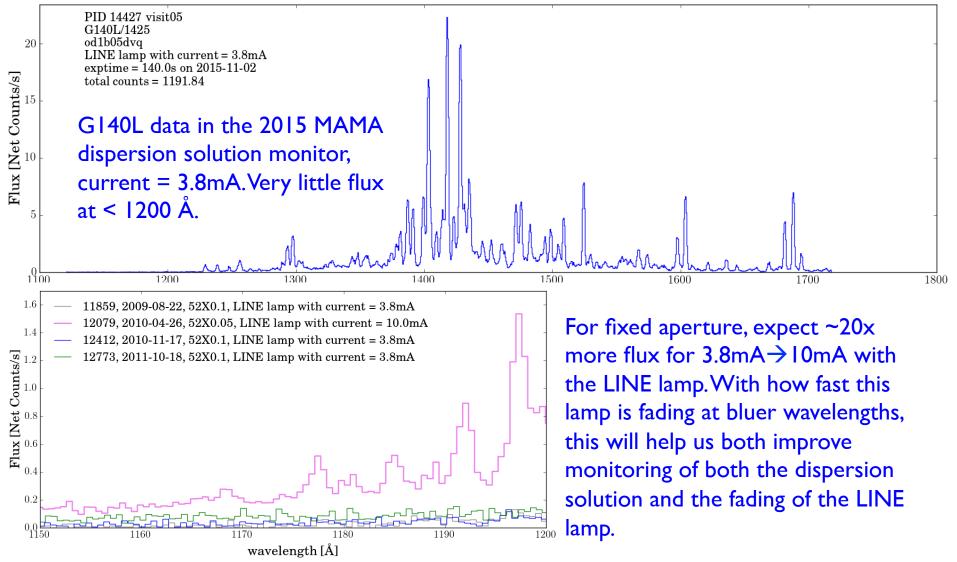
Purpose	To monitor the wavelength and spatial distortion maps for some configurations of the STIS/CCD.		
Description	nternal wavecals will be obtained with all 6 gratings (G230LB, G230MB, G430L, G430M, G750L, G750M) supported for use with the CCD. All observations will be obtained with the 52x0.1 aperture, which maps to 2 pixels at the CCD. As in previous cycles, the HITM1 lamp will be used, rather than the INE lamp. The HITM1 lamp has a more favorable spatial illumination pattern, dropping by only a factor of 3 at row 900, relative to the peak brightness at row 420.		
Fraction GO/GTO Programs Supported	30% of STIS total exposure time.		
Resources Required: Observations	3 internal orbits		
Resources Required: Analysis	4 FTE weeks		
Products	Update wavelength dispersion reference file as needed, ISR, and a summary in the end of cycle ISR.		
Accuracy Goals	0.2 pixels; wavelength accuracy for row 900. Wavelength coefficients are tabulated every 32 rows in the CCD dispersion (_dsp) reference file. Exposure times in this program have typically been chosen to yield a S/N ratio of at least 10 per pixel in row 900 after combining 32 rows. This constraint must be satisfied in the left, middle, and right thirds of the image. Existing HITM1 wavecals were used to estimate exposure times assuming no significant degradation since Cycle 18.		
Scheduling & Special Requirements	These observations are taken once per cycle		
Changes from Cycle 23	No changes.		

STIS MAMA Spectroscopic Dispersion Solution Monitor PI: Molly Peeples

Purpose	To monitor the wavelength dispersion solutions of some STIS MAMA configurations.	
Description	Internal wavecals will be obtained in all gratings at primary and secondary central wavelengths chosen to cover Cycle 24 use. There is also overlap with choices of configurations used with previous calibration programs which will enable long-term monitoring. This program uses the LINE lamp for a total of approximately 8 hours, typically at a lamp current of 10 mA, consuming about 0.5% of the 15000 mAhour lifetime. Extra-deep wavecals are included for some echelle modes and for some first order modes to ensure detection of weak lines. All orbits < 1800s.	
Fraction GO/GTO Programs Supported	55% of STIS total exposure time.	
Resources Required: Observations	7 internal orbits	
Resources Required: Analysis	4 FTE weeks	
Products	Update wavelength dispersion reference file as needed, ISR, and a summary in the end of cycle ISR.	
Accuracy Goals	0.1 pixels internal wavelength precision.	
Scheduling & Special Requirements	These observations are taken once per cycle	
Changes from Cycle 23	We will enforce that the medium current of 10mA is used for all modes, as is done for auto wavecals taken by GOs, as opposed to the 3.8mA this program used previously. This will give us both deeper wavecals in the 3 relevant modes as well as allow us to more easily track the fading of the LINE lamp with time.	

STIS MAMA Spectroscopic Dispersion Solution Monitor PI: Molly Peeples





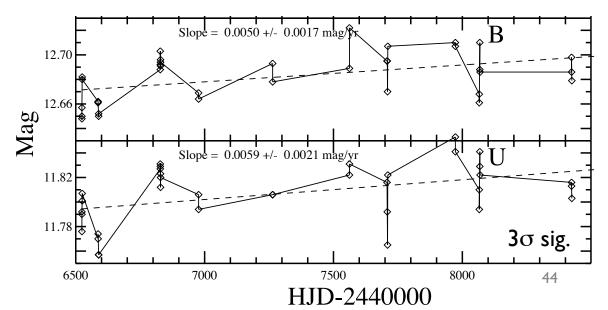
STIS Special Program

Monitoring the 3 Primary WD Standard Stars Ralph Bohlin

Changes from Cycle 23	New program		
Scheduling & Special Requirements	SAA-free orbits; no monthly offset		
Accuracy Goals	1%; Minimum signal to noise of 50 per resolution element at least sensitive wavelength		
Products	Increased knowledge of uncertainties in the TDS, verification of the TDS corrections in the TDSTAB, summary in end of cycle ISR		
Resources Required: Analysis	5 FTE weeks: 3 FTE weeks for sensitivity analysis, 2 weeks for ISR		
Resources Required: Observations	external orbits		
Fraction GO/GTO Programs Supported	35% of STIS prime exposures		
Description	Three hydrogen white dwarfs, G191B2B, GD153, and GD71, will be observed with the L-mode gratings to reveal any variability in observations of GRW+70D5824 and AGK+81D266, which are routinely monitored every 4 months in the L-modes. A lapse of three years in observations of the three standards necessitates a return visit i Cycle 24. All spectroscopic observations rely on TDS corrections derived from observations of GRW+70D5824 and AGK+81D266. Verification of the stability of the monitor stars is crucial for maintaining absolute flux calibration uncertainties. Observations requested: I orbit for G191B2B G230LB, G430L, and G750L CCD observations, two orbits each for GD153 and GD71 with G140L and G230L MAMA observations and G230LB, G430L, and G750L CCD observations.		
Purpose	Verify the spectrophotometric stability of the stars observed for the MAMA and CCD spectroscopic sensitivity monitors in the low-resolution gratings, to reveal any intrinsic changes in brightness not caused by sensitivity		

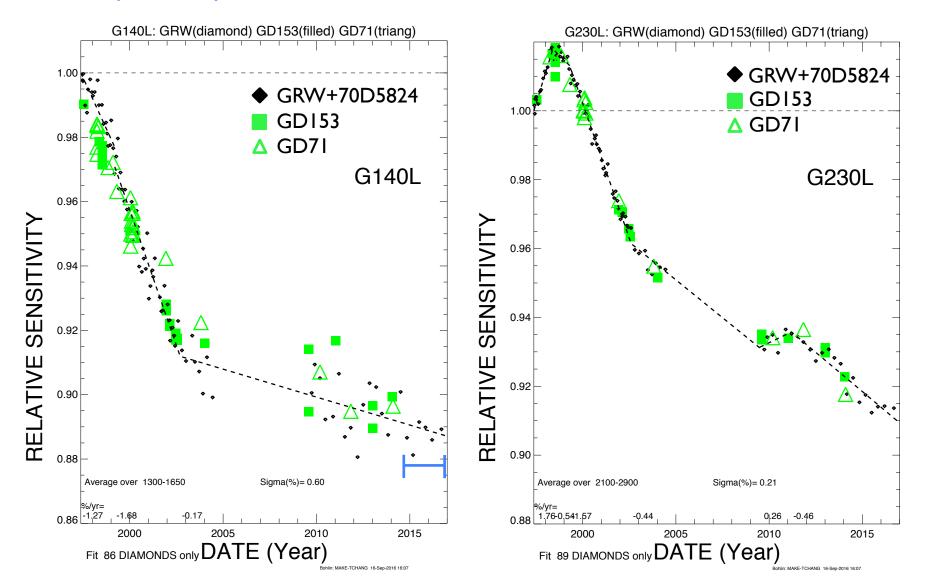
- Fundamental standard stars should be observed to safe-guard against possible variability of the sensitivity monitor stars, GRW+70D5824 and AGK+81D266.
- Historically, STIS observed three standard WD stars, as frequently as every year, but there was a lapse in observations the past three years.
- Brighter G191B2B requires one orbit and can only be observed with the CCD modes G230LB, G430L, and G750L.
- Fainter WDs GD153 and GD71 will be observed with CCD modes, plus MAMA modes G140L and G230L, and will require two orbits each.

Ground-based photometry hints at possible long-term variability of GRW +70D5824 (Bohlin & Landolt 2015)

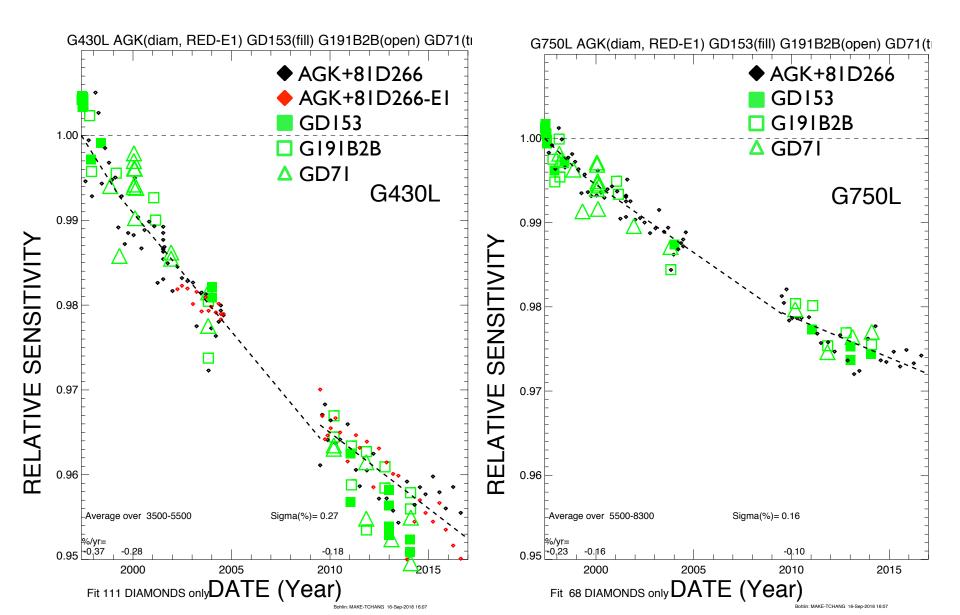


MAMA Spectroscopic Sensitivity Trends

A lapse of \sim 3 years has occurred since last observations



CCD Spectroscopic Sensitivity Trends

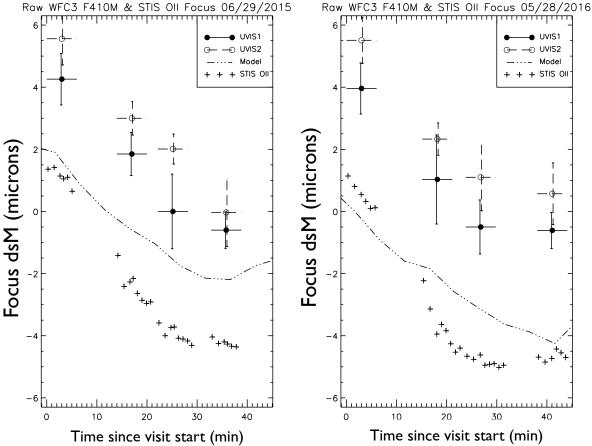


Contingency Program

STIS Focus Parallel Measurements Charles Proffitt

Changes from Cycle 23	None. Will request to activate program if focus monitor indicates significant focus change.		
	The ORIENT requirement of 255 to match previous iterations of this setup and ensure that the same stars are viewed in WFC3 and ACS will force execution of this program to occur between 26-May-2017 and 13-Jul-2017.		
Accuracy Goals	< I micron of equivalent secondary despace		
Products	A measurement of the focus offset between STIS and ACS and WFC3. Possible recommendations for adjustments to the STIS corrector.		
Resources Required: Analysis			
Resources Required: Observations	I external orbit, I parallel orbit		
Fraction GO/GTO Programs Supported	100% of STIS external observations are affected by the focus		
Description	A UV bright star will be observed with STIS F28X50OII while parallel observations are done of rich star fields in 47 Tuc using WFC3 F410M and ACS F502N. This prime/parallel grouping is repeated 4 times for STIS+WFC3 using a small dither pattern. During two of these iterations there is also time to include a parallel ACS F502N image. Phase retrieval analysis should allow measurement of the relative focus of the three instruments independent of any uncertainties in the breathing model.		
Purpose	o determine the focus offset between the STIS OII filter and that of WFC3/UVIS and ACS/WFC. This will allow ny long term secular changes in the relative focus of the three instruments to be determined.		

STIS Focus Parallel Measurements



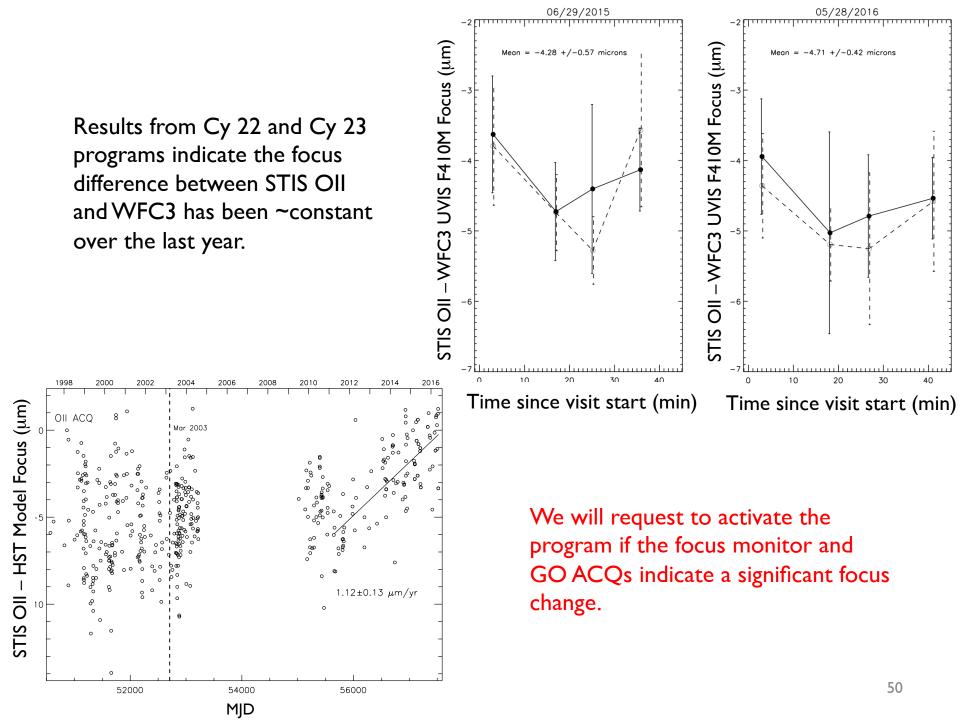
The focus offset between STIS F28X50OII images and other cameras can be used to monitor the stability of the STIS focus over time.

The WFC3 UVIS F410M images of 47 Tuc taken in program 14063 in Cy 22 and 14425 in Cy 23 provide dozens of stars suitable for phase retrieval. The ACS WFC F502N images provide several additional stars.

Visits of 47 Tuc field provide a direct measure of the stability of the STIS focus over time

- Repeating the exact pointing and exposures provide a good differential measurement, regardless of any systematic uncertainties

- Taking parallel images with three instruments provides a measurement that is independent of the focus model 49



Backup Slides

STIS Sensitivity Accuracies

• Uncertainties specified in STIS IHB.

Attribute	Accuracy	Limiting Factors
CCD Spectroscopic A	ccuracies	
Absolute photometry ^a		Instrument stability
T madaa	5%	Correction of charge transfer efficiency
L modes		Time dependent photometric calibration
M modes	5%	Fringe correction (for $\lambda > 7500$ Å)
Relative photometry ^b		Instrument stability
(within an exposure)		Correction of charge transfer efficiency
		Time dependent photometric calibration
L modes	2%	Fringe correction (for $\lambda > 7500$ Å)
M modes	2%	

MAMA Spectroscopic Accuracies

Absolute photometry ^c L modes M modes Echelle modes ^d	4% 5% 8%	Instrument stability Time dependent photometric calibration
Relative photometry (within an exposure) ^e		Instrument stability Flat fields Echelle modes:
L modes M modes Echelle modes ^f	2% 2% 5%	Blaze shift correction accuracy Scattered light subtraction